

**IEEE-CPMT Switzerland Chapter &  
Swiss Federal Laboratories for Materials Science and Technology  
(EMPA)**

**Seminar on  
Reliability of Electronic Components & Systems**  
EMPA Dübendorf, 24th June 2013

Dear IEEE CPMT members,

The CPMT Switzerland Chapter in cooperation with the Swiss Federal Laboratories for Materials Science and Technology (EMPA) organizes a half-day seminar covering various topics within the field of reliability of electronic components and systems. The goal of this seminar is to provide a platform where people can exchange their activities, interests and solutions.

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## Seminar Program

**14:20 – 14:40 Welcome and introduction**

- Welcome address (Hamit Duran, IEEE CPMT chapter chair)
- Introduction to EMPA (Günter Grossmann, EMPA)

**14:40 – 15:55 Technical presentations – Part 1**

- Reliability of large area solder joints: Numerical modeling and experimental results (Dr. Gernot Riedel, ABB)
- Solder bump process optimization (Dr. René Zingg, Melexis)
- Reliability of the cohesiveness of diverse connection technologies (Jagoda Karlsson, Microdul)

**15:55 – 16:10 Short break / coffee**

**16:10 – 17:00 Technical presentations – Part 2**

- Design of accelerated tests for solder joints (Günter Grossmann, EMPA)
- Denser scalable IC packages require jumps in technology and reliability (Gerd Schlottig, IBM)

**17:00 – 18:00 Lab tour EMPA**

**18:00 – 19:00 Apéro / Networking**

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**Location:** EMPA Akademie, Überlandstrasse 129, 8600 Dübendorf, Switzerland  
(see attached instructions)  
**Date:** 24. June 2013  
**Time:** 14:20 – 19:00 (incl. EMPA lab visit)  
**Local contact:** Günter Grossmann (guenter.grossmann@empa.ch, +41 58 765 42 79)  
**Web:** [www.ieee.ch/chapters/cpmt](http://www.ieee.ch/chapters/cpmt), [www.empa.ch](http://www.empa.ch)

Please register by E-mail ([hamit.duran@ch.abb.com](mailto:hamit.duran@ch.abb.com)) before 17th June 2013